

**Search Notes**

Application/Control No.

10/767,373

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under  
Reexamination

TAKAYA ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
336	65, 83, 200, 232	12/27/2005	TTN
257	531	12/27/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR